

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/629,278	HUANG ET AL.
	<b>Examiner</b> Huyen X. Vo	<b>Art Unit</b> 2626

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
704	251; 236	12/24/2007	HV
704	270; 246	12/24/2007	HV
704	270.1	12/24/2007	HV